

DeepCover安全认证器, 带有1-Wire SHA-256和4Kb用户EEPROM

概述

特性

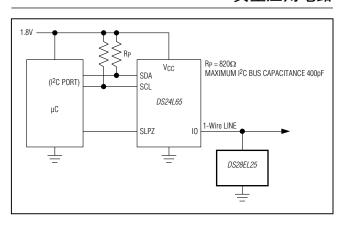
DeepCover®嵌入式安全方案采用多重先进的物理安全机 制保护敏感数据,提供业内最高等级的密钥存储安全保护。 Deepcover安全认证器(DS28EL25)将强加密、双向、安全 质询-应答安全认证功能与符合FIPS 180-3安全散列算法 (SHA-256)的方案结合在一起。4Kb用户可编程EEPROM阵 列为应用数据提供了非易失存储空间,具有附加保护的存 储器存储SHA-256操作的密码和用户存储器控制设置。每 片器件都拥有唯一的64位ROM识别码(ROM ID),由工厂 写至芯片。唯一的ROM ID用作加密运算的基本输入参数, 也作为应用中的电子序列号。双向安全模型允许主机系统 和嵌入式从DS28EL25之间的双向安全认证。主机系统采 用从至主安全认证,安全验证连接或嵌入式DS28EL25的 真实可靠性。主至从安全认证用干保护DS28EL25用户存 储器不被非法主机更改。DS28EL25产生的SHA-256信息 验证代码(MAC)根据用户存储器中的数据、片上密码、主 机随机质询及64位ROM ID计算得到。DS28EL25通过单 触点1-Wire[®]总线进行高速通信,通信符合1-Wire协议, 在多器件的1-Wire网络中, ROM ID作为节点地址。

应用

联网器械的安全认证 打印机墨盒ID/安全认证 许可管理参考设计 系统知识产权保护 传感器/配件识别和校准 可配置系统的安全功能设置 加密系统的密码发生和交换

- ◆ 基于SHA-256的对称加密双向安全认证模型
- ◆ 专用的硬件SHA加速引擎产生SHA-256 MAC
- ◆ 利用高位计数、用户可编程密码及输入质询进行有效的 安全认证
- ◆ 4096位用户EEPROM存储器,分为16页,每页256位
- ◆ 用户可编程、不可擦除EEPROM保护模式,包括:安全 认证、读/写保护以及OTP/EPROM仿真
- ◆ 唯一的工厂编程64位识别码
- ◆ 单触点1-Wire接口与主机通信,速度可达76.9kbps
- ◆ 工作范围: 1.8V ±5%, -40°C至+85°C
- ◆ 5µA (典型值)低待机功耗
- ◆ ±8kV人体模式ESD保护(典型值)
- ♦ 6引脚TDFN封装

典型应用电路



定购信息在数据资料的最后给出。

1-Wire和DeepCover是Maxim Integrated Products, Inc.的注册商标。

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ABSOLUTE MAXIMUM RATINGS

IO Voltage Range to GND0.5V	to 4.0V	Storage Temperature Range	55°C to +125°C
IO Sink Current	20mA	Lead Temperature (soldering, 10s)	+300°C
Operating Temperature Range40°C to	+85°C	Soldering Temperature (reflow)	+260°C
Junction Temperature	+150°C		

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ELECTRICAL CHARACTERISTICS

 $(T_A = -40^{\circ}C \text{ to } +85^{\circ}C, \text{ unless otherwise noted.}) \text{ (Note 1)}$

PARAMETER	SYMBOL	CONDITIONS	MIN TY	P MAX	UNITS
IO PIN: GENERAL DATA					
1-Wire Pullup Voltage	V _{PUP}	(Note 2)	1.71	1.89	V
1-Wire Pullup Resistance	R _{PUP}	V _{PUP} = 1.8V ±5% (Note 3)	300	750	Ω
Input Capacitance	C _{IO}	(Notes 4, 5)	150	0	pF
Input Load Current	ΙL	IO pin at V _{PUP}	5	19.5	μΑ
High-to-Low Switching Threshold	V _{TL}	(Notes 6, 7)	0.65 x \	/ _{PUP}	V
Input Low Voltage	V _{IL}	(Notes 2, 8)		0.3	V
Low-to-High Switching Threshold	V _{TH}	(Notes 6, 9)	0.75 x \	/ _{PUP}	V
Switching Hysteresis	V _{HY}	(Notes 6, 10)	0.3	}	V
Output Low Voltage	V _{OL}	I _{OL} = 4mA (Note 11)		0.4	V
Recovery Time	t _{REC}	$R_{PUP} = 750\Omega$ (Notes 2, 12)	5		μs
Time-Slot Duration	t _{SLOT}	(Notes 2, 13)	13		μs
IO PIN: 1-Wire RESET, PRESENC	E-DETECT	CYCLE	,		
Reset Low Time	t _{RSTL}	(Note 2)	48	80	μs
Reset High Time t _{RSTH}		(Note 14)	48		μs
Presence-Detect Sample Time	t _{MSP}	(Notes 2, 15)	8	10	μs
IO PIN: 1-Wire WRITE					
Write-Zero Low Time	t _{WOL}	(Notes 2, 16)	8	16	μs
Write-One Low Time	t _{W1L}	(Notes 2, 16)	1	2	μs
IO PIN: 1-Wire READ					
Read Low Time	t _{RL}	(Notes 2, 17)	1	2 - δ	μs
Read Sample Time	t _{MSR}	(Notes 2, 17)	$t_{RL} + \delta$	2	μs
EEPROM					
Programming Current IPROG		V _{PUP} = 1.89V (Notes 5, 18)		1	mA
Programming Time for a 32-Bit Segment or Page Protection tpRD		(Note 19)		10	ms
Programming Time for the Secret t _{PRS}		(Note 20)		200	ms
Write/Erase Cycling Endurance	N _{CY}	T _A = +85°C (Notes 21, 22)	100k		_
Data Retention	t _{DR}	T _A = +85°C (Notes 23, 24, 25)	10		Years

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ELECTRICAL CHARACTERISTICS (continued)

 $(T_A = -40^{\circ}C \text{ to } +85^{\circ}C, \text{ unless otherwise noted.}) \text{ (Note 1)}$

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
SHA-256 ENGINE						
Computation Current	I _{CSHA}	V _{PUP} = 1.89V (Notes 5, 18)			1	mA
Computation Time	tCSHA	(Notes 5, 26)			3	ms

- **Note 1:** Limits are 100% production tested at $T_A = +25^{\circ}C$ and/or $T_A = +85^{\circ}C$. Limits over the operating temperature range and relevant supply voltage range are guaranteed by design and characterization. Typical values are not guaranteed.
- Note 2: System requirement
- **Note 3:** Maximum allowable pullup resistance is a function of the number of 1-Wire devices in the system and 1-Wire recovery times. The specified value here applies to systems with only one device and with the minimum 1-Wire recovery times.
- **Note 4:** Typical value represents the internal parasite capacitance when V_{PUP} is first applied. Once the parasite capacitance is charged, it does not affect normal communication.
- **Note 5:** Guaranteed by design and/or characterization only; not production tested.
- **Note 6:** V_{TL}, V_{TH}, and V_{HY} are a function of the internal supply voltage, which is a function of V_{PUP}, R_{PUP}, 1-Wire timing, and capacitive loading on IO. Lower V_{PUP}, higher R_{PUP}, shorter t_{REC}, and heavier capacitive loading all lead to lower values of V_{TI}, V_{TH}, and V_{HY}.
- Note 7: Voltage below which, during a falling edge on IO, a logic-zero is detected.
- Note 8: The voltage on IO must be less than or equal to V_{ILMAX} at all times when the master is driving IO to a logic-zero level.
- Note 9: Voltage above which, during a rising edge on IO, a logic-one is detected.
- Note 10: After V_{TH} is crossed during a rising edge on IO, the voltage on IO must drop by at least V_{HY} to be detected as logic-zero.
- Note 11: The I-V characteristic is linear for voltages less than 1V.
- Note 12: Applies to a single device attached to a 1-Wire line.
- Note 13: Defines maximum possible bit rate. Equal to 1/(twoLMIN + trecmin).
- Note 14: An additional reset or communication sequence cannot begin until the reset high time has expired.
- Note 15: Interval after t_{RSTL} during which a bus master can read a logic 0 on IO if there is a DS28EL25 present. The power-up presence detect pulse could be outside this interval. See the *Typical Operating Characteristics* for details.
- Note 16: ϵ in Figure 11 represents the time required for the pullup circuitry to pull the voltage on IO up from V_{IL} to V_{TH} . The actual maximum duration for the master to pull the line low is $t_{W1LMAX} + t_F \epsilon$ and $t_{W0LMAX} + t_F \epsilon$, respectively.
- Note 17: δ in Figure 11 represents the time required for the pullup circuitry to pull the voltage on IO up from V_{IL} to the input-high threshold of the bus master. The actual maximum duration for the master to pull the line low is $t_{RLMAX} + t_F$.
- **Note 18:** Current drawn from IO during the EEPROM programming interval or SHA-256 computation. The pullup circuit on IO during the programming and computation interval should be such that the voltage at IO is greater than or equal to V_{PUPMIN}. A low-impedence bypass of R_{PUP} activated during programming and computation is the recommended way to meet this requirement.
- Note 19: Refer to the full data sheet.

Note 20: Refer to the full data sheet.

- Note 21: Write-cycle endurance is tested in compliance with JESD47G.
- Note 22: Not 100% production tested; guaranteed by reliability monitor sampling.
- Note 23: Data retention is tested in compliance with JESD47G.
- **Note 24:** Guaranteed by 100% production test at elevated temperature for a shorter time; equivalence of this production test to the data sheet limit at operating temperature range is established by reliability testing.
- **Note 25:** EEPROM writes can become nonfunctional after the data retention time is exceeded. Long-term storage at elevated temperatures is not recommended.

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ELECTRICAL CHARACTERISTICS (continued)

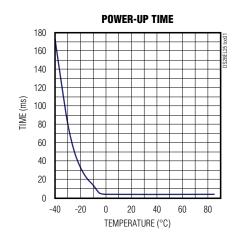
 $(T_A = -40^{\circ}C \text{ to } +85^{\circ}C, \text{ unless otherwise noted.}) \text{ (Note 1)}$

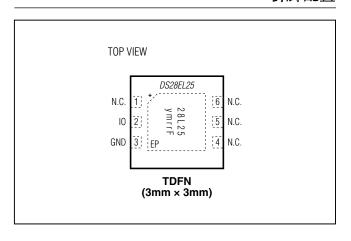
Note 26: Refer to the full data sheet.

典型工作特性

引脚配置

 $(V_{PUP} = 1.71V, V_{IL} = 0.3V)$





引脚说明

引脚	名称	功能
3	GND	地基准。
2	10	1-Wire总线接口。开漏信号,需要外部上 拉电阻。
1, 4, 5, 6	N.C.	无连接。
_	EP	裸焊盘。均匀焊接至电路板的接地区域以确保正常工作。更多信息请参见应用笔记3273: Exposed Pads:A Brief Introduction。

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定购信息

器件	温度范围	引脚–封装
DS28EL25Q+T	-40°C至+85°C	6 TDFN-EP* (2.5k pcs)

⁺表示无铅(Pb)/符合RoHS标准的封装。

封装信息

如需最近的封装外形信息和焊盘布局(占位面积),请查询china. maximintegrated.com/packages。请注意,封装编码中的"+"、"#"或"-"仅表示RoHS状态。封装图中可能包含不同的尾缀字符,但封装图只与封装有关,与RoHS状态无关。

封装类型	封装编码	外形编号	焊盘布局编号
6 TDFN-EP	T633+2	<u>21-0137</u>	90-0058

T = 卷带包装。

^{*}EP = 裸焊盘。

数据资料缩写本

DS28EL25

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修订历史

修订号	修订日期	说明	修改页
0	12/12	最初版本。	_

Maxim北京办事处

北京8328信箱 邮政编码100083 免费电话: 800 810 0310 电话: 010-6211 5199 传真: 010-6211 5299



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